

Notice of References Cited

Application/Control No.

10/058,830

Applicant(s)/Patent Under
Reexamination
COHEN ET AL.

Examiner

Tan Dean D. Nguyen

Art Unit

3689

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,082,401	07-2006	Behrens et al.	705/7
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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